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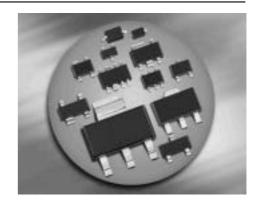


Silicon N_Channel MOSFET Tetrode

- Short-channel transistor
 with high S / C quality factor
- For low-noise, gain-controlled input stage up to 1 GHz
- Pb-free (RoHS compliant) package 1)
- Qualified according AEC Q101







ESD (Electrostatic discharge) sensitive device, observe handling precaution!

Туре	Package	Pin Configuration					Marking	
BF998	SOT143	1=S	2=D	3=G2	4=G1	-	-	MOs
BF998R	SOT143R	1=D	2=S	3=G1	4=G2	-	-	MRs

Maximum Ratings

Parameter	Symbol	Value	Unit
Drain-source voltage	V_{DS}	12	V
Continuous drain current	I _D	30	mA
Gate 1/ gate 2-source current	±/ _{G1/2SM}	10	
Total power dissipation	P _{tot}	200	
<i>T</i> _S ≤ 76 °C, BF998, BF998R			
Storage temperature	$T_{ m stg}$	-55 150	°C
Channel temperature	T_{ch}	150	

Thermal Resistance

Parameter	Symbol	Value	Unit
Channel - soldering point ²⁾ , BF998, BF998R	R _{thchs}	≤ 370	K/W

¹Pb-containing package may be available upon special request

 $^{^2}$ For calculation of R_{thJA} please refer to Application Note Thermal Resistance



Electrical Characteristics at $T_A = 25$ °C, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
DC Characteristics			•		•
Drain-source breakdown voltage	V _{(BR)DS}	12	-	_	V
$I_{D} = 10 \mu A$, $V_{G1S} = -4 V$, $V_{G2S} = -4 V$					
Gate 1 source breakdown voltage	±V _{(BR)G1SS}	8	-	12	
$\pm I_{G2S} = 10 \text{ mA}, \ V_{G2S} = V_{DS} = 0$					
Gate2 source breakdown voltage	±V _{(BR)G2SS}	8	-	12	
$\pm I_{G2S} = 10 \text{ mA}, \ V_{G2S} = V_{DS} = 0$					
Gate 1 source leakage current	±I _{G1SS}	-	-	50	nA
$\pm V_{G1S} = 5 \text{ V}, \ V_{G2S} = V_{DS} = 0$					
Gate 2 source leakage current	± <i>I</i> _{G2SS}	-	-	50	nA
$\pm V_{G2S} = 5 \text{ V}, \ V_{G2S} = V_{DS} = 0$					
Drain current	I _{DSS}	5	9	15	mA
$V_{DS} = 8 \text{ V}, \ V_{G1S} = 0 \ , \ V_{G2S} = 4 \text{ V}$					
Gate 1 source pinch-off voltage	-V _{G1S(p)}	-	8.0	2.5	V
$V_{\rm DS} = 8 \text{ V}, \ V_{\rm G2S} = 4 \text{ V}, \ I_{\rm D} = 20 \ \mu\text{A}$					
Gate 2 source pinch-off voltage	- V _{G2S(p)}	-	0.8	2	
$V_{\rm DS} = 8 \text{ V}, \ V_{\rm G1S} = 0 \ , \ I_{\rm D} = 20 \ \mu\text{A}$					

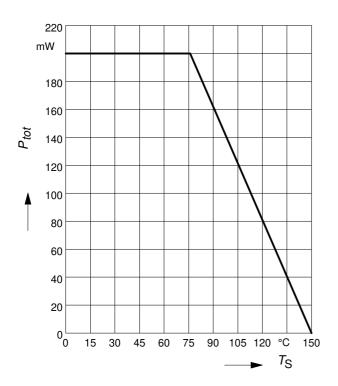


Electrical Characteristics at $T_A = 25$ °C, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
AC Characteristics (verified by random sa	mpling)				
Forward transconductance	g_{fs}	20	24	-	-
$V_{DS} = 8 \text{ V}, I_{D} = 10 \text{ mA}, V_{G2S} = 4 \text{ V}$					
Gate1 input capacitance	C_{g1ss}	-	2.1	2.5	pF
$V_{DS} = 8 \text{ V}, I_{D} = 10 \text{ mA}, V_{G2S} = 4 \text{ V},$					
f = 10 MHz					
Gate 2 input capacitance	$C_{ m g2ss}$	-	1.2	-	pF
$V_{DS} = 8 \text{ V}, I_{D} = 10 \text{ mA}, V_{G2S} = 4 \text{ V},$					
f = 10 MHz					
Feedback capacitance	C _{dg1}	-	25	-	fF
$V_{DS} = 8 \text{ V}, I_{D} = 10 \text{ mA}, V_{G2S} = 4 \text{ V},$					
f = 10 MHz					
Output capacitance	C_{dss}	-	1.1	-	pF
$V_{\rm DS} = 8 \text{ V}, I_{\rm D} = 10 \text{ mA}, V_{\rm G2S} = 4 \text{ V},$					
f = 10 MHz					
Power gain	G_{p}				dB
$V_{\rm DS} = 8 \text{ V}, I_{\rm D} = 10 \text{ mA}, V_{\rm G2S} = 4 \text{ V},$					
f = 45 MHz		-	28	-	
$V_{\rm DS} = 8 \text{ V}, I_{\rm D} = 10 \text{ mA}, V_{\rm G2S} = 4 \text{ V},$					
f = 800 MHz		-	20	-	
Noise figure	F				dB
$V_{\rm DS} = 8 \text{ V}, I_{\rm D} = 10 \text{ mA}, V_{\rm G2S} = 4 \text{ V},$					
f = 45 MHz		-	2.8	-	
$V_{\rm DS} = 8 \text{ V}, I_{\rm D} = 10 \text{ mA}, V_{\rm G2S} = 4 \text{ V},$			4.0		
f = 800 MHz		-	1.8	-	
Gain control range	ΔG_{p}	40	50	-	
$V_{\rm DS} = 8 \text{ V}, \ V_{\rm G2S} = 4 \dots -2 \text{ V}, \ f = 800 \text{ MHz}$					



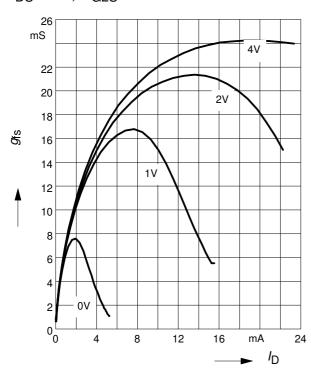
Total power dissipation $P_{tot} = f(T_S)$ BF998, BF998R



Gate 1 forward transconductance

$$g_{fS} = f(I_D)$$

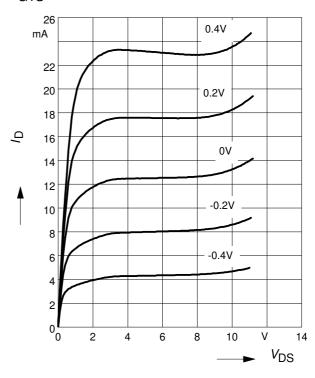
 $V_{DS} = 5V$, $V_{G2S} = Parameter$



Output characteristics $I_D = f(V_{DS})$

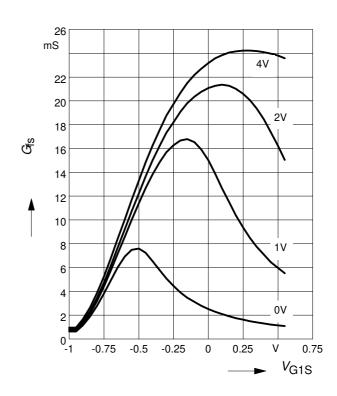
$$V_{G2S} = 4 \text{ V}$$

 $V_{\rm G1S}$ = Parameter



Gate 1 forward transconductance

$$g_{\text{fs1}} = f\left(V_{\text{G1S}}\right)$$

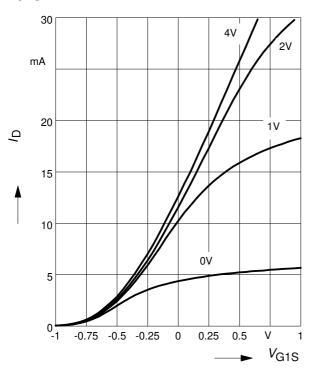




Drain current $I_D = f(V_{G1S})$

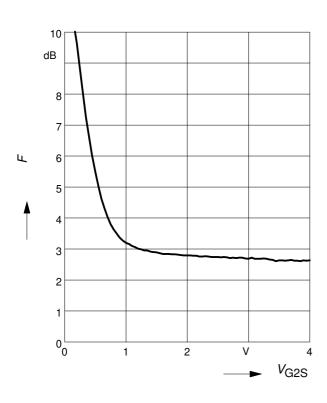
 $V_{\rm DS} = 5V$

 $V_{\rm G2S}$ = Parameter



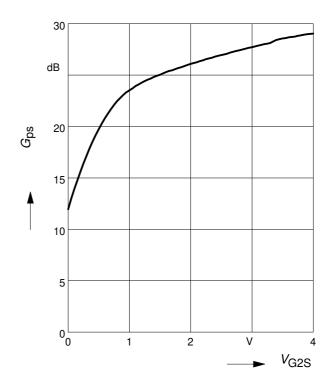
Noise figure $F = f(V_{G2S})$

f = 45 MHz



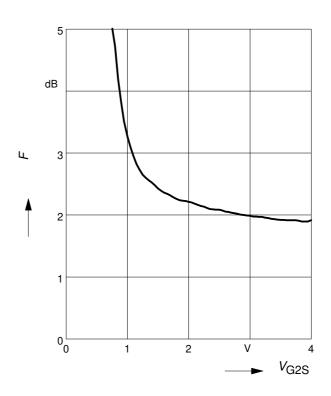
Power gain $G_{ps} = f(V_{G2S})$

f = 45 MHz



Noise figure $F = f(V_{G2S})$

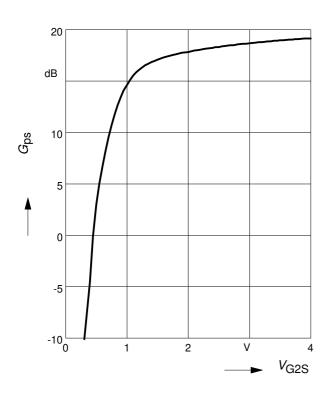
f = 800 MHz

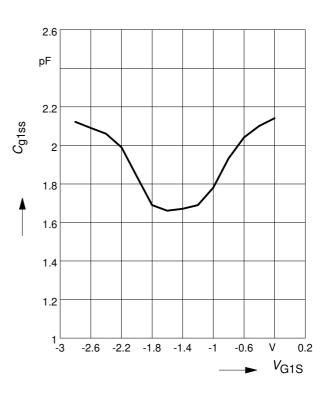




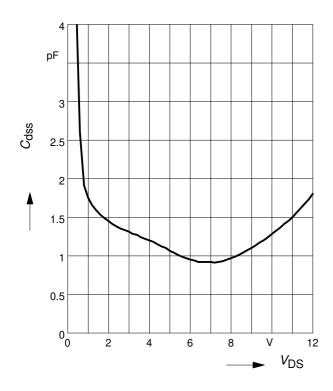
Power gain $G_{ps} = f(V_{G2S})$ f = 800 MHz

Gate 1 input capacitance $C_{g1ss} = f(V_{G1s})$



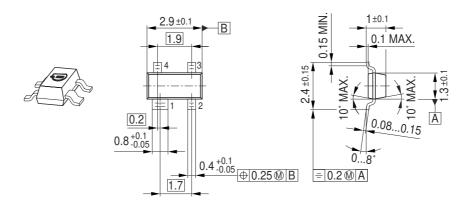


Output capacitance $C_{dSS} = f(V_{DS})$

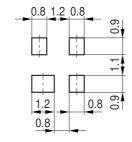




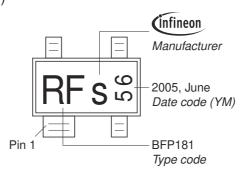
Package Outline



Foot Print

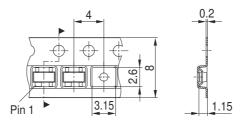


Marking Layout (Example)



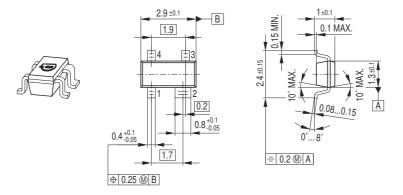
Standard Packing

Reel ø180 mm = 3.000 Pieces/Reel Reel ø330 mm = 10.000 Pieces/Reel

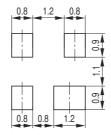




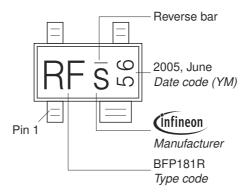
Package Outline



Foot Print

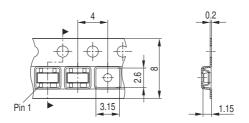


Marking Layout (Example)



Standard Packing

Reel ø180 mm = 3.000 Pieces/Reel Reel ø330 mm = 10.000 Pieces/Reel





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